

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SAVAGE ET AL.	
		Examiner Kan Yuen	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,872,775 A	02-1999	Saints et al.	370/342
*	B	US-6,046,780 A	04-2000	Tani, Yusuke	348/722
*	C	US-6,188,728 B1	02-2001	Hurst, Robert Norman	375/240.16
*	D	US-6,434,168 B1	08-2002	Kari, Hannu	370/521
*	E	US-6,480,467 B1	11-2002	Hernandez-Valencia, Enrique	370/230
*	F	US-2003/0007459 A1	01-2003	Yi et al.	370/252
*	G	US-2003/0063566 A1	04-2003	Abramovitch et al.	370/241
*	H	US-2003/0072229 A1	04-2003	Hasegawa et al.	369/47.3
*	I	US-2004/0199388 A1	10-2004	Armbruster et al.	704/251
*	J	US-2005/0047423 A1	03-2005	Kaul et al.	370/401
*	K	US-6,944,123 B1	09-2005	Moon, Billy G.	370/216
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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